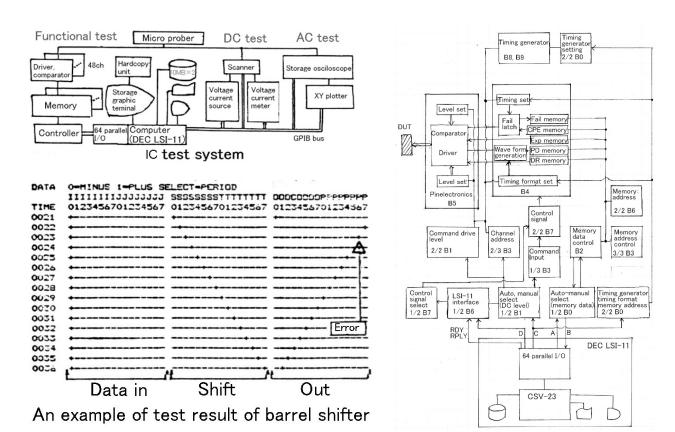
7 IC tester



(M. Esashi, M. Ohtomo: Fabrication of Functional LSI Tester, Joint Convention of Electrical Academic Societies in Tohoku Region, 2D21 (1984))(in Japanese)

Connection between boards

Pin electronics (electrical connection to IC pad)